

**Notice of References Cited**

Application/Control No:

09/512,336

Applicant(s)/Patent Under  
Reexamination  
FUKUDA, SEIICHI

Examiner

Kin-Chan Chen

Art Unit

1765

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*		Document Number	Date	Name	Classification	
		Country Code-Number-Kind Code	MM-YYYY			
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		Country Code-Number-Kind Code	MM-YYYY				
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**NON-PATENT DOCUMENTS**

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